

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BECHHOFER ET AL.	
		09/680,923	Examiner	Art Unit
		Susanna M. Diaz	3623	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-20010055627	05-2001	Peterson et al.	
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Daniell, Mark Haynes. "Strategy and Volatility: Risk and Global Strategic Challenge." Balance Sheet, vol. 8, no. 4, pages 24-36, 2000 (excerpt from author's book published March 2000).
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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